

Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/613,332	LEE ET AL.
	Examiner Mark K. Han	Art Unit 3767

ISSUE CLASSIFICATION				
ORIGINAL		CROSS REFERENCE(S)		
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)	
604	96.01	606	194	
INTERNATIONAL CLASSIFICATION		428	36.9	
A	6	1	M	29/00
B	2	9	C	47/00
				/
				/
				/
<i>Mark</i> Mark K Han 3/16/06 (Assistant Examiner) (Date)			MICHAEL J. HAYES PRIMARY EXAMINER <i>Michael Hayes 3/20/06</i> (Primary Examiner) (Date)	
<i>J. Lee 3-21-06</i> (Legal Instruments Examiner) (Date)			Total Claims Allowed: 17 O.G. Print Claim(s) 1 O.G. Print Fig. 1	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1		16	31	61	91	121	151
2		32		62	92	122	152
3		33		63	93	123	153
4		34		64	94	124	154
5		35		65	95	125	155
6		36		66	96	126	156
1	7	37		67	97	127	157
2	8	38		68	98	128	158
3	9	39		69	99	129	159
4	10	40		70	100	130	160
5	11	41		71	101	131	161
	12	42		72	102	132	162
6	13	43		73	103	133	163
7	14	44		74	104	134	164
	15	45		75	105	135	165
8	16	46		76	106	136	166
	17	47		77	107	137	167
9	18	48		78	108	138	168
	19	49		79	109	139	169
10	20	50		80	110	140	170
11	21	51		81	111	141	171
	22	52		82	112	142	172
12	23	53		83	113	143	173
13	24	54		84	114	144	174
14	25	55		85	115	145	175
15	26	56		86	116	146	176
17	27	57		87	117	147	177
	28	58		88	118	148	178
29		59		89	119	149	179
	30	60		90	120	150	180